## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10785550	THURAU ET AL.
Examiner	Art Unit
Nguyen, Helen	3736

	SEARCH	IED	
Class	Subclass	Date	Examiner
600	573, 577-578, 580	12/20/2006	HQN

SEARCH NOT	res	
Search Notes	Date	Examiner
Inventor search performed in PALM	12/20/2006	HQN
See EAST Search History	12/20/2006	HQN

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